Notice of References Cited Application/Control No. 10/594,053 Examiner OMAR GHOWRWAL Applicant(s)/Patent Under Reexamination NISHIO, AKIHIKO Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0136271 A1	09-2002	Hiramatsu et al.	375/141
*	В	US-6,735,178 B1	05-2004	Srivastava et al.	370/252
*	С	US-2003/0073409 A1	04-2003	Nobukiyo et al.	455/67.1
*	D	US-2005/0037766 A1	02-2005	Hans et al.	455/450
*	Е	US-2002/0126645 A1	09-2002	Ryu, Seung Moon	370/342
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	х						

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